

Notice of References Cited	Application/Control No. 10/525,270		Applicant(s)/Patent Under Reexamination SUNDSTROM, HENRIK	
	Examiner HANH T. BUI		Art Unit 2192	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0096581	05-2003	Takamine, Kouichi	455/84
*	B	US-7,380,093	05-2008	Shimazaki et al.	711/171
*	C	US-2006/0041518	02-2006	Blair et al.	705/080
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
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NON-PATENT DOCUMENTS

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